

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09/897,584	DEWITTE ET AL.
	Examiner	Art Unit
	Cheyne D Ly	1631

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
A	US-5,495,423	02-1996	DeLisi et al.	703/2
B	US-6,251,620 B1	06-2001	Hatada et al.	435/15
C	US-			
D	US-			
E	US-			
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G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N					
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P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
U	News Focus, Science, November 1, 2002, Volume 298, Pages 948-950.	
V	Jan Drenth, Principles of Protein X-ray Crystallography, 1995, Springer-Verlag, page 16.	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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